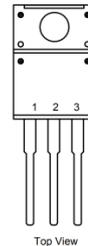
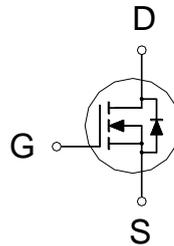


**PRODUCT SUMMARY**

$V_{(BR)DSS}$	$R_{DS(ON)}$	$I_D$
600V	0.94Ω	5A



1. GATE
2. DRAIN
3. SOURCE



**ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25 ° C Unless Otherwise Noted)**

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		$V_{DS}$	600	V
Gate-Source Voltage		$V_{GS}$	±30	V
Continuous Drain Current <sup>2</sup>	T <sub>C</sub> = 25 ° C	$I_D$	5	A
	T <sub>C</sub> = 100 ° C		3.2	
Pulsed Drain Current <sup>1</sup>		$I_{DM}$	11	
Avalanche Current <sup>3</sup>		$I_{AS}$	1.1	
Avalanche Energy <sup>3</sup>		$E_{AS}$	46	mJ
Power Dissipation	T <sub>C</sub> = 25 ° C	$P_D$	25	W
	T <sub>C</sub> = 100 ° C		10	
Operating Junction & Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	° C

**THERMAL RESISTANCE RATINGS**

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$		5	° C / W
Junction-to-Ambient	$R_{\theta JA}$		62.5	

<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>Ensure that the channel temperature does not exceed 150°C.

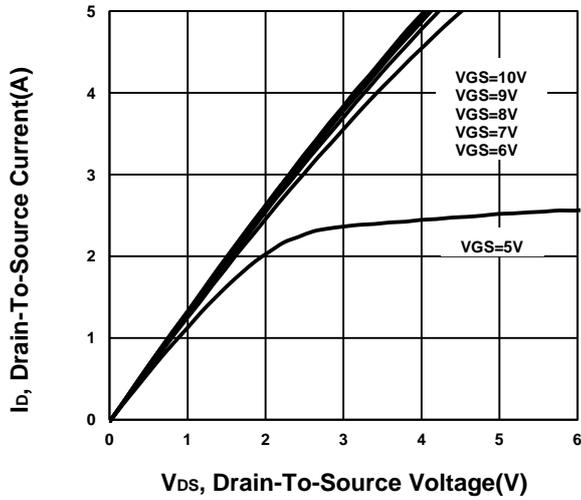
<sup>3</sup>V<sub>DD</sub> = 50V , L = 75mH ,starting T<sub>J</sub> = 25°C.

**ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25 ° C, Unless Otherwise Noted)**

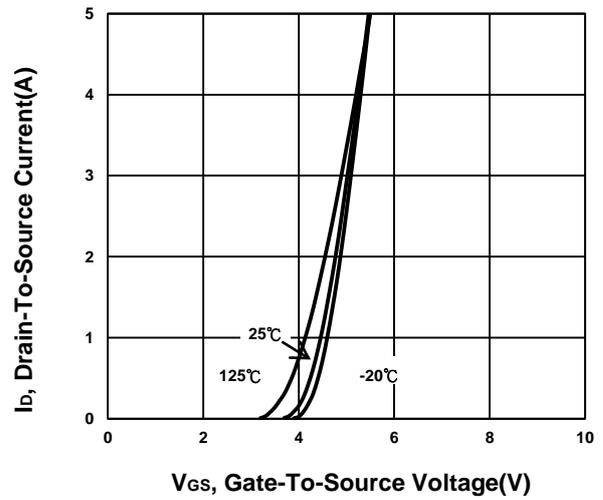
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNITS
			MIN	TYP	MAX	
<b>STATIC</b>						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	600			V
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA	2	3.2	4	
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0V, V <sub>GS</sub> = ±30V			±100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 600V, V <sub>GS</sub> = 0V			1	μA
		V <sub>DS</sub> = 480V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 100 ° C			10	
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 2.5A		0.77	0.94	Ω
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> = 15V, I <sub>D</sub> = 2.5A		4.8		S
<b>DYNAMIC</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 100V, f = 250KHz		334		pF
Output Capacitance	C <sub>oss</sub>			18		
Reverse Transfer Capacitance	C <sub>rss</sub>			1.4		
Gate Resistance	R <sub>g</sub>	f = 1MHz		25		Ω
Total Gate Charge <sup>4</sup>	Q <sub>g</sub>	V <sub>DS</sub> = 480V, V <sub>GS</sub> = 10V, I <sub>D</sub> = 2.5 A		10		nC
Gate-Source Charge <sup>4</sup>	Q <sub>gs</sub>			1.9		
Gate-Drain Charge <sup>4</sup>	Q <sub>gd</sub>			4.8		
Turn-On Delay Time <sup>4</sup>	t <sub>d(on)</sub>	V <sub>DD</sub> = 300V, I <sub>D</sub> ≅ 2.5A, V <sub>GS</sub> = 10V, R <sub>GEN</sub> = 25Ω		14		nS
Rise Time <sup>4</sup>	t <sub>r</sub>			26		
Turn-Off Delay Time <sup>4</sup>	t <sub>d(off)</sub>			71		
Fall Time <sup>4</sup>	t <sub>f</sub>			69		
<b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T<sub>J</sub> = 25 ° C)</b>						
Continuous Current	I <sub>S</sub>				5	A
Forward Voltage	V <sub>SD</sub>	I <sub>F</sub> = 5A, V <sub>GS</sub> = 0V			1.2	V
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 2.5A, di <sub>F</sub> /dt = 100A/μs		172		nS
Reverse Recovery Charge	Q <sub>rr</sub>				1.1	

<sup>4</sup>Independent of operating temperature.

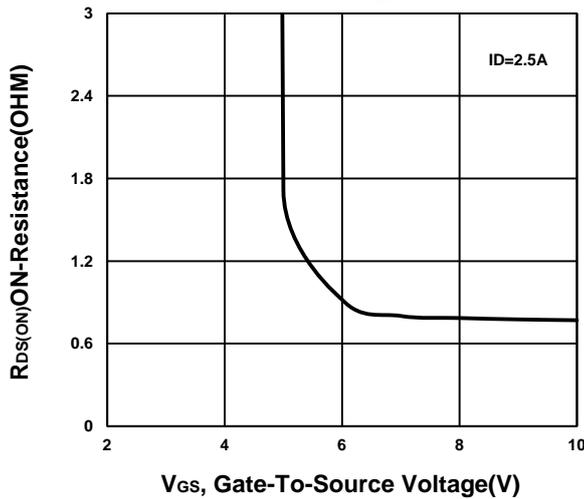
**Output Characteristics**



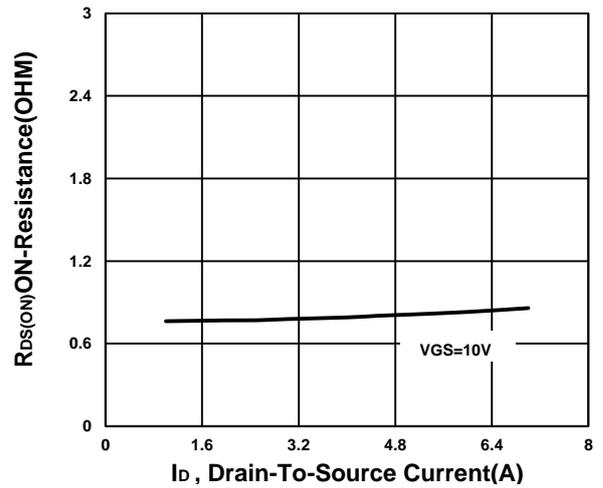
**Transfer Characteristics**



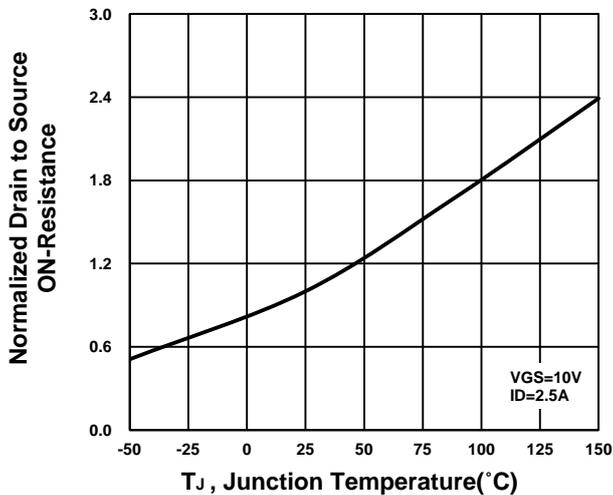
**On-Resistance VS Gate-To-Source Voltage**



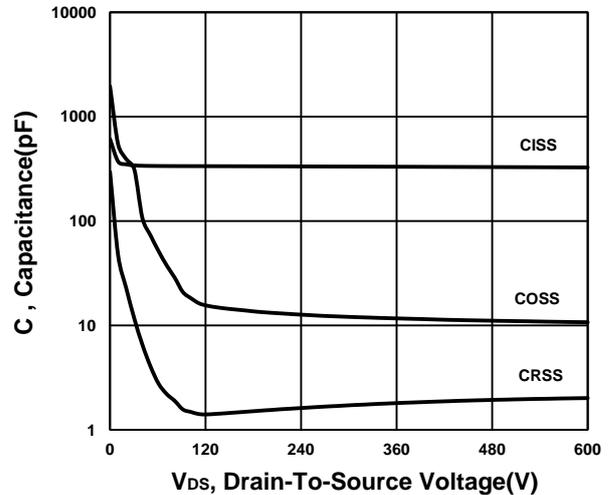
**On-Resistance VS Drain Current**



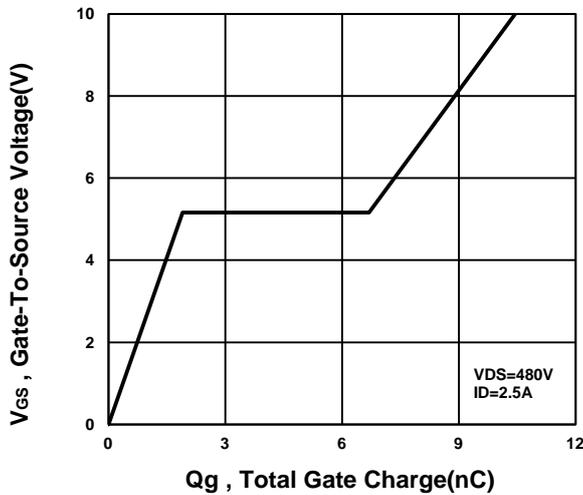
**On-Resistance VS Temperature**



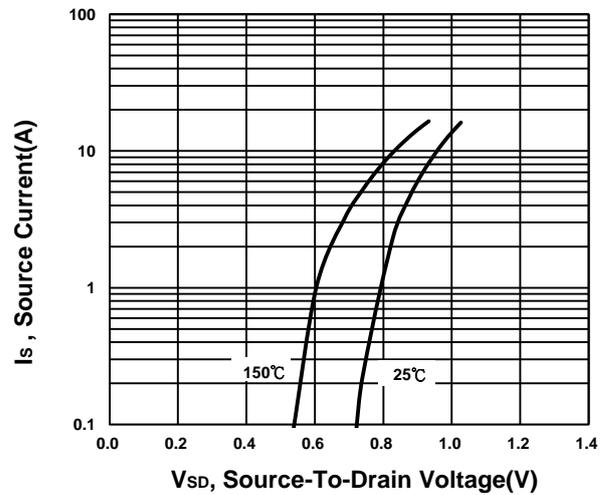
**Capacitance Characteristic**



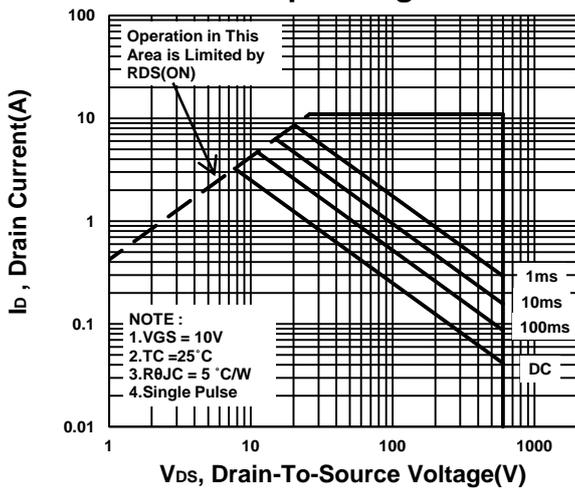
**Gate charge Characteristics**



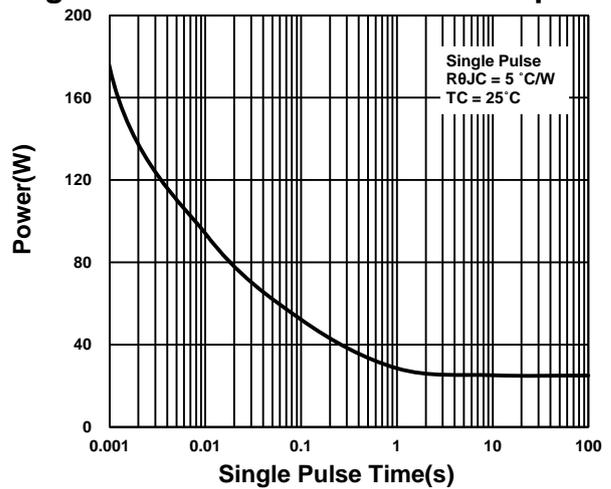
**Source-Drain Diode Forward Voltage**



**Safe Operating Area**



**Single Pulse Maximum Power Dissipation**



**Transient Thermal Response Curve**

